

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10573155	MAEKAWA ET AL.
	Examiner	Art Unit
	Thien F Tran	2895

SEARCHED

Class	Subclass	Date	Examiner
438	406, 455, 458	02/24/2009	TT

SEARCH NOTES

Search Notes	Date	Examiner
Search history printout	02/24/2009	TT
Search history printout	02/25/2009	TT

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

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